

Notice of References Cited	Application/Control No. 09/867,967	Applicant(s)/Patent Under Reexamination SHEN ET AL.	
	Examiner Nhon T. Diep	Art Unit 2613	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,763,070	07-2004	Lee, Yuen-Wen	375/240.2
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
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	L	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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